

Notice of References Cited

Application/Control No.

10/523,234

Applicant(s)/Patent Under
Reexamination
NAKAMURA ET AL.

Examiner

Nicholas S. Ulrich

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0101203 A1	05-2003	Chen et al.	707/513
*	B	US-6,125,204	09-2000	Nakatsuka et al.	382/173
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

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